

Notice of References Cited		Application/Control No.	Applicant(s)/Patent Under Reexamination IMAZUMI ET AL.	
		Examiner Shean C. Wu	Art Unit 1795	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2002/0176046	11-2002	Kitamura et al.	349/153
*	B	US-2006/0004140	01-2006	Asano et al.	525/031
	C	US-			
	D	US-			
	E	US-			
	F	US-			
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	M	US-			

FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

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